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of

Complete if Known				
Application Number	10/765,071			
Filing Date	January 28, 2004			
First Named Inventor	Chae-Whan Lim et al.			
Art Unit	2624			
Examiner Name	Mehta, Bhavesh M.			
Attorney Docket Number	46245			

U.S. PATENT DOCUMENTS					
	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
Examiner Initials		Number-Kind Code (if known)			
AA		U.S. 5,995,659	11-1999	Chakraborty et al.	382/281
AA		U.S. 5,995,657	11-1999	Sunakawa	382/170
AA		U.S. 5,809,183	09-1998	Serizawa et al.	382/301
					_

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number- Kind Code (if known)	Publication Date MM-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	т
AA		EP 1 215 626 A1	06-2002	Jiebo Luo		X
		EP 0 824 246 A3	06-2002	James Bollman et al.		X
		EP 0 863 475 A3	02-2001	Isamu Haneda et al.		X
		EP 0 863 475 A2	09-1998	Isamu Haneda et al.		X
AA	9	EP 0 824 246 A2	02-1998	James Bollman et al.		X
						\vdash

Examiner City No.		- 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1			
		R. CATTONI et al., "Geometric Layout Analysis Techniques For Document Image Understanding: A Review", ITC-IRST Technical Report, January 1998, pages 1-68, Trento Italy.			
		W. SCHERL et al., "Automatic Separation Of Text, Graphic And Picture Segments In Printed Material", Pattern Recognition In Practice, Siemens AG, Zentrale Forschung und Entwicklung, Lehrstuhl für Nachrichtentechnik, Technische Universität München, 21 May 1980, pages 213-221 and page 272, Vol. PROC. 1980, May 1980, North Holland Publishing Co., Amsterdam NL.			
		Tioliana i abiloning doi, pariotoladiri NE.			

Examiner Signature	/Amara Abdi/	Date Considered	01/25/2007
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